

Product Summary

$V_{(BR)DSS}$	$R_{DS(ON)} \text{ max}$	$I_D \text{ max}$ $T_A = 25^\circ\text{C}$
30V	13m Ω @ $V_{GS} = 10\text{V}$	9.5A
	14m Ω @ $V_{GS} = 4.5\text{V}$	9.0A

Features and Benefits

- DIOFET utilizes a unique patented process to monolithically integrate a MOSFET and a Schottky in a single die to deliver:
 - Low $R_{DS(ON)}$ – minimize conduction losses
 - Low V_{SD} – reducing the losses due to body diode conduction
 - Low Q_{rr} – lower Q_{rr} of the integrated Schottky reduces body diode switching losses
 - Low gate capacitance (Q_g/Q_{gs}) ratio – reduces risk of shoot-through or cross conduction currents at high frequencies
- Small form factor thermally efficient package enables higher density end products
- Occupies just 33% of the board area occupied by SO-8 enabling smaller end product
- 100% UIS (Avalanche) rated
- 100% R_g tested
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. “Green” Device (Note 3)**
- **Qualified to AEC-Q101 Standards for High Reliability**

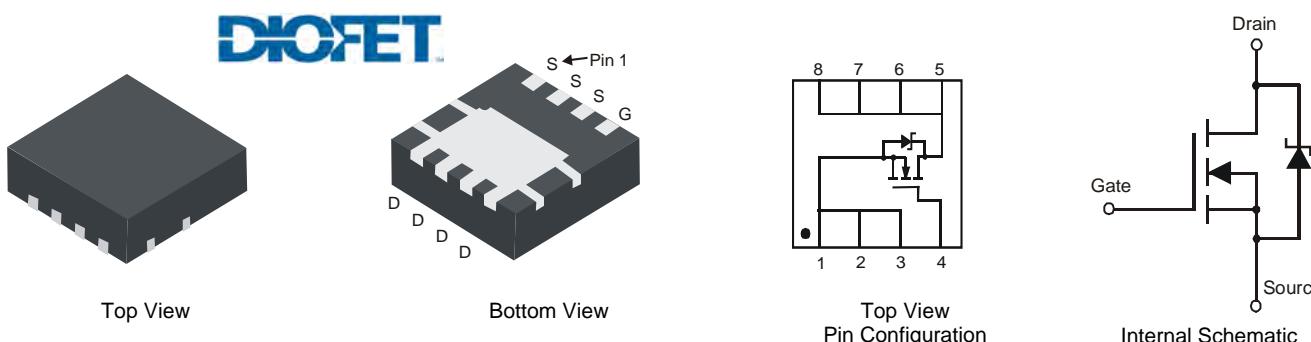
Description and Applications

This MOSFET has been designed to minimize the on-state resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- Power Management Functions
- DC-DC Converters

Mechanical Data

- Case: POWERDI3333-8
- Case Material: Molded Plastic, "Green" Molding Compound.
UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish — Matte Tin annealed over Copper leadframe.
Solderable per MIL-STD-202, Method 208 (e3)
- Weight: 0.072 grams (approximate)



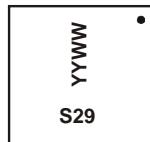
Ordering Information (Note 4)

Part Number	Case	Packaging
DMS3014SFG-7	POWERDI3333-8	2000/Tape & Reel
DMS3014SFG-13	POWERDI3333-8	3000/Tape & Reel

Notes:

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
2. See <http://www.diodes.com> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
4. For packaging details, go to our website at <http://www.diodes.com>.

Marking Information



S29 = Product Type Marking Code
 YYWW = Date Code Marking
 YY = Last digit of year (ex: 11 = 2011)
 WW = Week code (01 ~ 53)

Maximum Ratings @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V_{DSS}	30	V
Gate-Source Voltage			V_{GSS}	± 12	V
Continuous Drain Current (Note 6) $V_{GS} = 10\text{V}$	Steady State	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	I_D	9.5 7.6	A
	$t < 10\text{s}$	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	I_D	13.0 9.7	A
Continuous Drain Current (Note 6) $V_{GS} = 4.5\text{V}$	Steady State	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	I_D	9.0 7.4	A
	$t < 10\text{s}$	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	I_D	12.2 9.3	A
Pulsed Drain Current (10 μs pulse, duty cycle = 1%)			I_{DM}	80	A
Maximum Continuous Body Diode Forward Current (Note 6)			I_S	3.0	A
Avalanche Current (Note 7) $L = 0.1\text{mH}$			I_{AR}	30	A
Repetitive Avalanche Energy (Note 7) $L = 0.1\text{mH}$			E_{AR}	45	mJ

Thermal Characteristics @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 5)		P_D	1	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	$R_{\theta JA}$	131	°C/W
	$t < 10\text{s}$		72	°C/W
Total Power Dissipation (Note 6)		P_D	2.1	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady state	$R_{\theta JA}$	63	°C/W
	$t < 10\text{s}$		35	°C/W
Thermal Resistance, Junction to Case (Note 6)		$R_{\theta JC}$	7.1	°C/W
Operating and Storage Temperature Range		T_J, T_{STG}	-55 to +150	°C

Notes:
 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
 7. I_{AR} and E_{AR} rating are based on low frequency and duty cycles to keep $T_J = 25^\circ\text{C}$

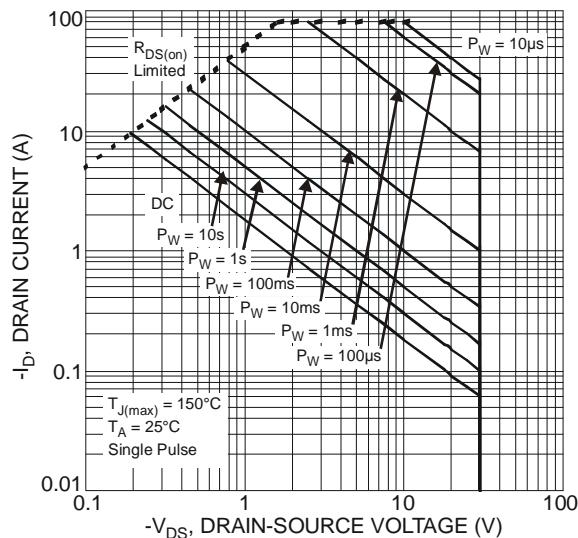


Fig. 1 SOA, Safe Operation Area

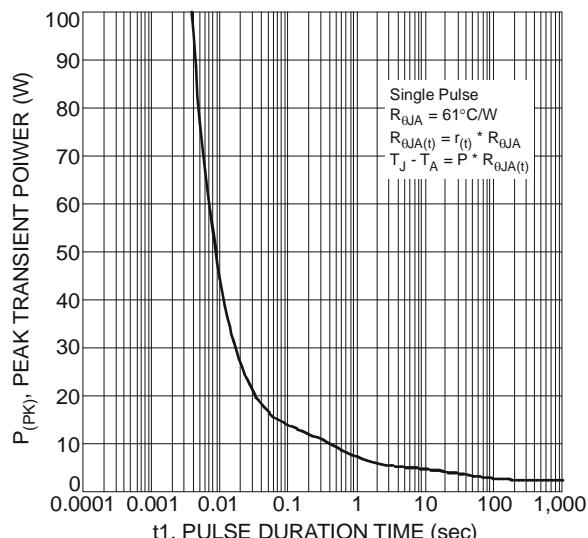


Fig. 2 Single Pulse Maximum Power Dissipation

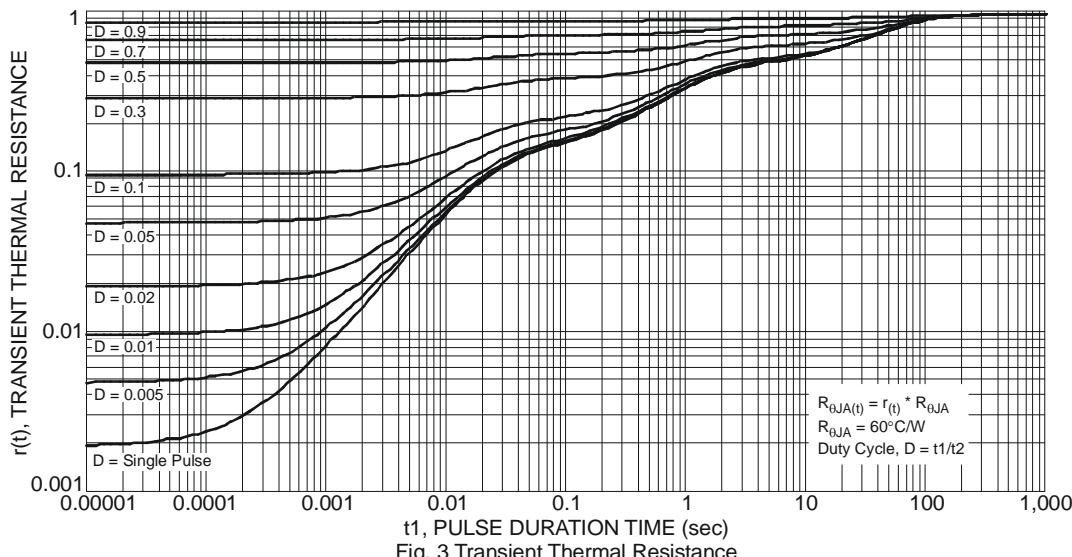
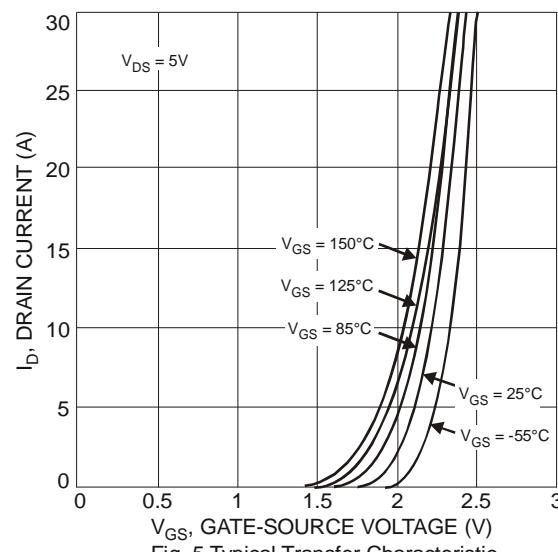
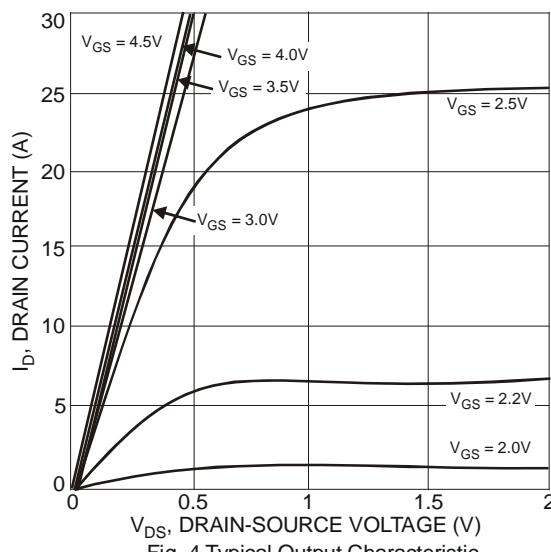


Fig. 3 Transient Thermal Resistance

Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV_{DSS}	30	-	-	V	$V_{\text{GS}} = 0\text{V}$, $I_{\text{D}} = 250\mu\text{A}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	100	μA	$V_{\text{DS}} = 30\text{V}$, $V_{\text{GS}} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	-	-	± 100	nA	$V_{\text{GS}} = \pm 12\text{V}$, $V_{\text{DS}} = 0\text{V}$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$V_{\text{GS(th)}}$	1.0	-	2.2	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_{\text{D}} = 250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{\text{DS}}(\text{ON})$	-	9	13	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}$, $I_{\text{D}} = 10.4\text{A}$
		-	10	14		$V_{\text{GS}} = 4.5\text{V}$, $I_{\text{D}} = 10.4\text{A}$
Forward Transfer Admittance	$ Y_{\text{fs}} $	-	23	-	S	$V_{\text{DS}} = 5\text{V}$, $I_{\text{D}} = 10.4\text{A}$
Diode Forward Voltage	V_{SD}	-	0.4	0.55	V	$V_{\text{GS}} = 0\text{V}$, $I_{\text{S}} = 1\text{A}$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C_{iss}	-	2296	4310	pF	$V_{\text{DS}} = 15\text{V}$, $V_{\text{GS}} = 0\text{V}$, $f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	-	164	-	pF	
Reverse Transfer Capacitance	C_{rss}	-	120	-	pF	
Gate Resistance	R_{g}	0.26	1.3	2.34	Ω	$V_{\text{DS}} = 0\text{V}$, $V_{\text{GS}} = 0\text{V}$, $f = 1\text{MHz}$
Total Gate Charge $V_{\text{GS}} = 4.5\text{V}$	Q_{g}	-	19.3	-	nC	$V_{\text{DS}} = 15\text{V}$, $V_{\text{GS}} = 10\text{V}$, $I_{\text{D}} = 10.4\text{A}$
Total Gate Charge $V_{\text{GS}} = 10\text{V}$	Q_{g}	-	45.7	-	nC	
Gate-Source Charge	Q_{gs}	-	5.0	-	nC	
Gate-Drain Charge	Q_{gd}	-	2.9	-	nC	
Turn-On Delay Time	$t_{\text{D(on)}}$	-	5.5	-	ns	
Turn-On Rise Time	t_{r}	-	24.4	-	ns	$V_{\text{GS}} = 10\text{V}$, $V_{\text{DS}} = 15\text{V}$, $R_{\text{g}} = 3\Omega$, $R_{\text{L}} = 1.2\Omega$
Turn-Off Delay Time	$t_{\text{D(off)}}$	-	33.1	-	ns	
Turn-Off Fall Time	t_{f}	-	6.6	-	ns	$I_{\text{F}} = 13\text{A}$, $\text{di}/\text{dt} = 500\text{A}/\mu\text{s}$
Reverse Recovery Time	t_{rr}	-	12.9	-	ns	
Reverse Recovery Charge	Q_{rr}	-	8.0	-	nC	

Notes: 8. Short duration pulse test used to minimize self-heating effect.
 9. Guaranteed by design. Not subject to product testing.



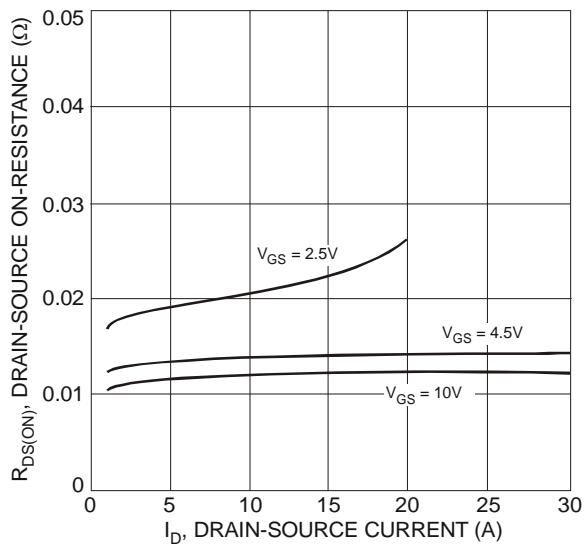


Fig. 6 Typical On-Resistance
vs. Drain Current and Gate Voltage

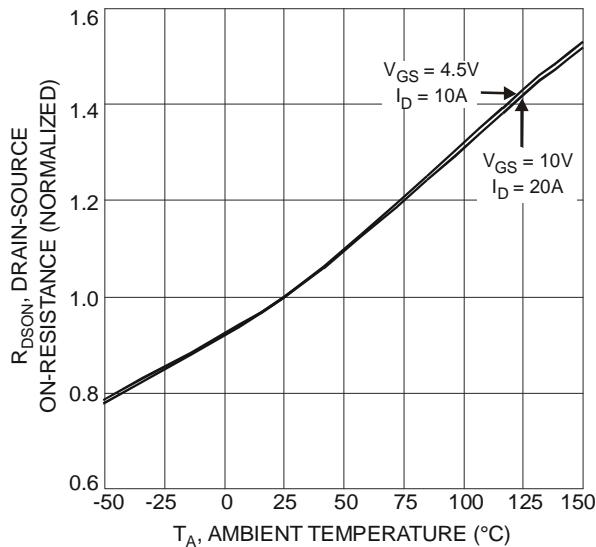


Fig. 8 On-Resistance Variation with Temperature

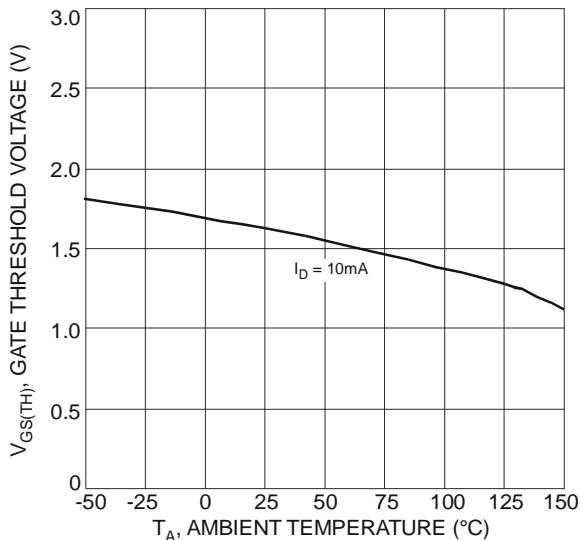


Fig. 10 Gate Threshold Variation vs. Ambient Temperature

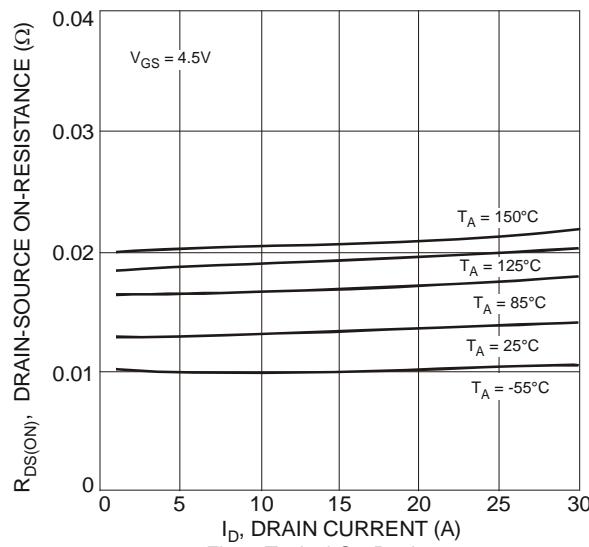


Fig. 7 Typical On-Resistance
vs. Drain Current and Temperature

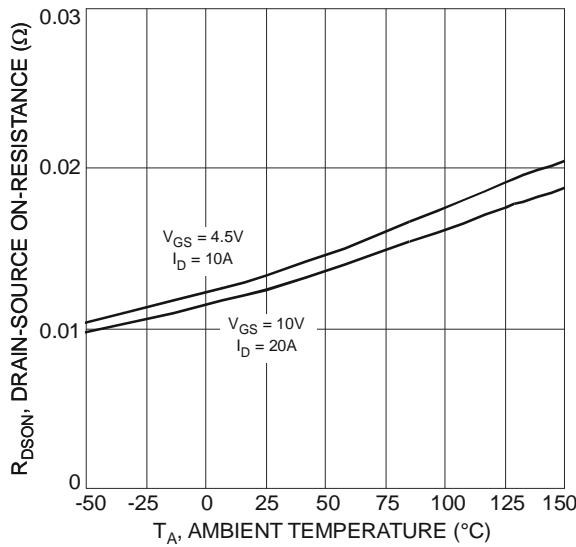


Fig. 9 On-Resistance Variation with Temperature

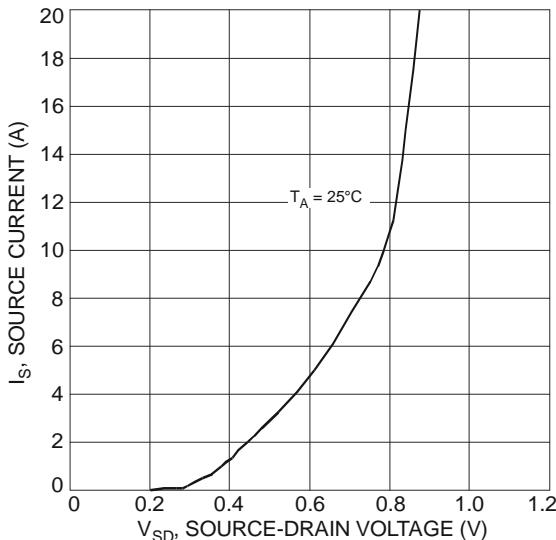


Fig. 11 Diode Forward Voltage vs. Current

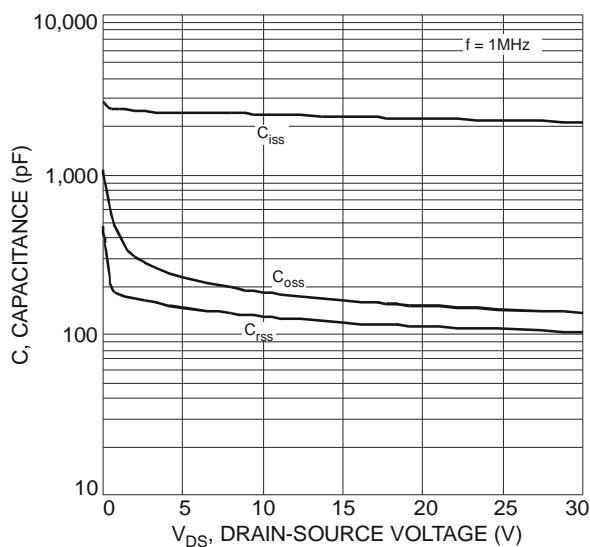


Fig. 12 Typical Total Capacitance

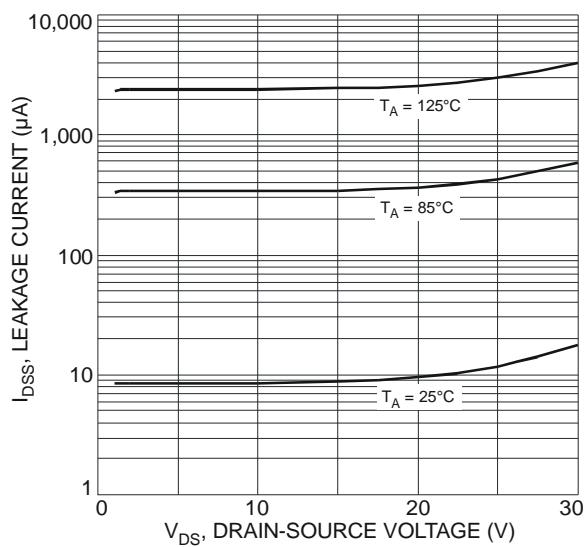


Fig. 13 Typical Leakage Current
vs. Drain-Source Voltage

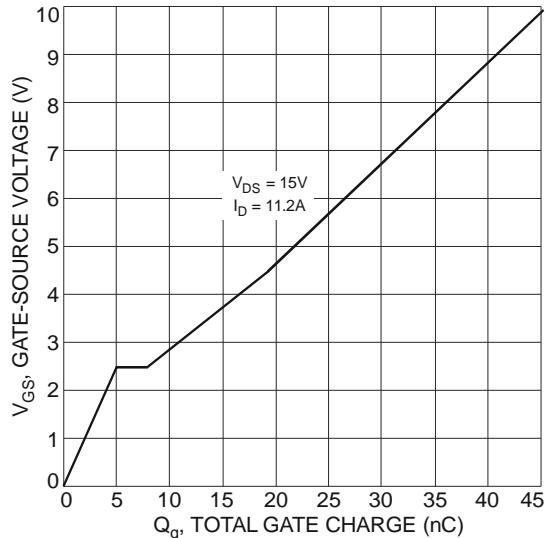
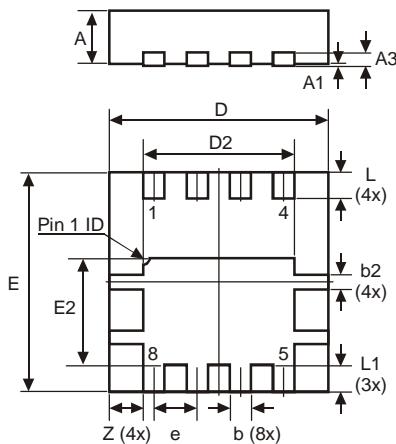


Fig. 14 Gate-Source Voltage vs. Total Gate Charge

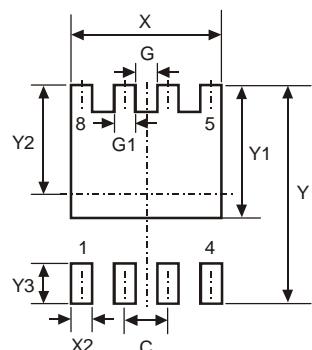
Package Outline Dimensions



POWERDI3333-8			
Dim	Min	Max	Typ
D	3.25	3.35	3.30
E	3.25	3.35	3.30
D2	2.22	2.32	2.27
E2	1.56	1.66	1.61
A	0.75	0.85	0.80
A1	0	0.05	0.02
A3	—	—	0.203
b	0.27	0.37	0.32
b2	—	—	0.20
L	0.35	0.45	0.40
L1	—	—	0.39
e	—	—	0.65
Z	—	—	0.515

All Dimensions in mm

Suggested Pad Layout



Dimensions	Value (in mm)
C	0.650
G	0.230
G1	0.420
Y	3.700
Y1	2.250
Y2	1.850
Y3	0.700
X	2.370
X2	0.420

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